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Structural, electrical and thermoelectric characterizations of bismuth-doped ZnO ceramic material

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ABSTRACT

Introduction: ZnO is a potential semiconductor material for thermoelectric (TE) applications at high temperature. In this study, doping Bi atoms aims to improve the power factor of ZnO ceramics. Based on the analyses of structural and TE properties, the enhancement in the Seebeck coefficient proves the benefit of Bi doping. **Methods:** ZnO and Bi-doped ZnO (BZO) ceramics were fabricated by a solid-state reaction at 1400°C in air. The Seebeck LSR-3 system measured both samples' TE properties, with a combined Hall effect at room temperature. The crystalline structure was analyzed through the X-ray diffraction (XRD) technique. **Results:** The XRD patterns show that all samples have polycrystalline hexagonal wurtzite structures. Although the crystallinity is enhanced, Bi doping significantly reduces the carrier concentration from 3.4×10^{19} to 1.1×10^{19} cm⁻³ at room temperature. As a result, at 500°C, the electrical conductivity, Seebeck coefficient, and power factor are 126 Scm⁻¹, -99 μ VK⁻¹, and 124 μ Wm⁻¹K⁻² for pure ZnO and 76 Scm⁻¹, -142 μ VK⁻¹, and 165 μ Wm⁻¹K⁻² for BZO ceramic, respectively. **Conclusion:** The power factor of Bi-doped ZnO is improved by 32% compared to pure ZnO at 500°C. The increase in the Seebeck coefficient is the main reason for the increase in the power factor.

Key words: Thermoelectric properties, ZnO ceramics, Bismuth doping, microstructure, power factor

INTRODUCTION

Thermoelectric (TE) materials can directly convert waste heat into electric energy thus, the efficiency of energy consumption is significantly enhanced¹. In addition, they also have some advantages, including no fume emission and quietness². One of the performances of TE materials is estimated by the power factor, $PF = \sigma S^2$, where σ and S are the electrical conductivity and Seebeck coefficient, respectively. This quantity represents the energy harvesting ability³. Currently, traditional alloy materials have highquality TE properties, such as Bi₂Te₃⁴ and Bi-Sb-Te⁵. However, these materials are limited by a short range of operation temperatures⁶. Therefore, the development of oxide materials is necessary to expand applications in a broad temperature range. Herein, ZnO is one of the promising oxide materials for TE modules at high temperature^{7–9}. ZnO has some benefits, such as a wide bandgap of 3.37 eV at room temperature and the ability to easily control structural and electrical properties through doping¹⁰. In previous reports, to improve PF, many elements were chosen for doping into ZnO, typically the IIIA group (Al^{11,12}, Ga^{13,14}, In¹⁵), or synthesizing hybrid nanostructures, such as compositing ZnO with graphene ^{16,17}. However, due to the good Zn substitution of the IIIA elements, the good crystalline structure and a high carrier concentration normally strongly increase the thermal conductivity of ZnO films. To solve this problem, there have been some reports on other metallic dopants in ZnO, such as Bi¹⁸, Sn¹⁹, Sb²⁰, and Ni²¹. These transition metals have large ionic radii and heavy atomic masses, which are beneficial for increasing phonon scattering and thus reducing the thermal conductivity of ZnO. Nevertheless, these elements are also easy to segregate in secondary phases and grain boundaries due to their low solid solubility in ZnO^{18,19}. It can significantly degrade the crystalline quality and thermoelectric performance of the host ZnO material.

In this work, bismuth (Bi) dopant is selected for investigation. Bi has a larger ionic radius (1.1 Å) than Zn (0.74 Å); however, it can still dissolve well in the ZnO network ²². The results show that Bi doping has the potential to increase the thermoelectric power factor of ZnO without creating secondary phase segregation. As a result, the 2 at.% Bi-doped ZnO ceramic shows an enhancement in the thermoelectric power factor by 32% at 500°C compared to pure ZnO.

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MATERIALS – METHODS

Both pure ZnO and Bi-doped ZnO (BZO) ceramics were prepared by a solid-state reaction in air. For the 2 at.% Bi-doped ZnO sample, a mixture of ZnO (99.9%, Merck), Bi₂O₃ (99.9995%, Alfa Aesar) powders, and 2nd-distilled water were mixed and ground in a corundum mill pot for 5 hours by using a planetary ball milling apparatus (Ceramic Instrument). After that, the slurry was completely dried at 120°C for 24 hours to evaporate the water. By using a stainless-steel die with an inner diameter of 3 cm, the dried mixture was pressed under 14 MPa produced from a hydraulic compressor. Finally, the green compact bodies were sintered at 1400°C in air for 3 hours at a temperature acceleration rate of 5°C/min. After the sintering process, the pellets were polished by sandpapers with 400 and 1000 grit to remove surface contaminants.

The crystalline characteristics of the samples were determined by an X-ray diffraction system (Bruker D8-Advance) with a radiation source (= 0.154 Å), the θ - 2θ configuration, and the 2θ region from 20° to 80° . The $10 \times 10 \times 1$ mm³-sized pieces were used for measuring the electrical parameters (carrier concentration, mobility) by a Hall measurement system (Ecopia HMS-3000) at room temperature. Before the Hall measurement, the ohmic electrodes were soldered at four corners of the square pieces by indium-tin alloy. The temperature-dependent electrical conductivity, Seebeck coefficient, and thermoelectric power factor of the samples were simultaneously obtained from room temperature to 500°C by using a Linseis LSR-3 system. All the measurements were analyzed at least three times for repeatability and error margin calculation.

RESULTS

Figure 1 shows XRD patterns of pure ZnO and BZO ceramics. According to the JCPDS No. 36-1451 standard, the diffraction peaks represent the hexagonal wurtzite structure of ZnO. The intensity of the diffraction peaks increases significantly when Bi^{3+} is doped. In addition, small strange peaks appear at approximately 31.31° and 36.94° in the BZO sample. They can belong to the secondary $-Bi_2O_3$ phase or spinel in host ZnO due to the limited solid solution of Bi_2O_3 powder²². To consider the effect of Bi doping on the structure of ZnO, some crystallographic parameters were determined.

First, the mean crystal size D is defined by Scherrer's equation 8,9 :

$$D = \frac{0.9\lambda}{\beta\cos\theta} \tag{1}$$

where λ is the wavelength of CuK α X-ray radiation (0.154 nm), β is the full width at half maximum (FWHM) of the diffraction peaks, and is the Bragg diffraction angle.

Second, the lattice strain η is an important parameter that suggests the perfection degree of crystals, as given by ^{23,24}:

$$\eta(\%) = \frac{\beta}{4\tan\theta} \times 100\% \tag{2}$$

The mean crystal size and lattice strain of ZnO and BZO are listed in Table 1. The positions of preferred planes, including (100), (002), and (101), tend to shift toward lower 2θ angles. This can be explained by Zn^{2+} substitution of Bi³⁺ with a larger radius²².

Third, the lattice constants of the samples are shown in Table 2, which can be estimated by the following equations 25,26 :

$$\alpha = \frac{\lambda}{\sqrt{3}\sin\theta_{(100)}} \tag{3}$$

$$c = \frac{\lambda}{\sin \theta_{(002)}} \tag{4}$$

where a and c are lattice constants along the a- and c-axes, respectively.

Figure 2 shows the electrical conductivity as a function of temperature. Generally, both samples behave as nondegenerate semiconductors because the electrical conductivity increases with temperature. At 500° C, the conductivities are found to be 126 Scm⁻¹ and 76 Scm⁻¹ for the ZnO and BZO ceramics, respectively. Over the range of room temperature – 500° C, the electrical conductivity of ZnO is degraded nearly 1.7 times by doping Bi.

To deeply consider the electrical properties, the charged carrier concentration and mobility of ZnO and BZO are listed in Table 3. The carrier concentration of the ZnO ceramic is 3.4×10^{19} cm⁻³, which is larger than that of the BZO sample $(1.1 \times 10^{19} \text{ cm}^{-3})$. On the other hand, the mobility increases slightly from 16.7 cm²/Vs (ZnO) to 18.2 cm²/Vs (BZO). The results of electrical conductivity obtained from the LSR-3 and Hall measurements are reasonable. Thus, the reduction in electrical conductivity can be mainly attributed to the degradation of the carrier concentration.

Figure 3 shows the Seebeck coefficient as a function of temperature. All samples have negative Seebeck coefficients, suggesting n-type semiconductor behavior. The absolute Seebeck coefficient increases remarkably with temperature. At 500°C, the BZO ceramic obtains a maximum of -142 μ VK⁻¹, which is an improvement of 70% compared to that of the ZnO sample (-99.34 μ VK⁻¹).



Figure 1: XRD patterns of pure ZnO (bottom) and BZO (top) ceramics. All the patterns are similar to the ZnO structure (JCPDS No. 36-1451).

Samples	ZnO			BZO		
Planes	(100)	(002)	(101)	(100)	(002)	(101)
2θ (°)	31.86	34.50	36.33	31.81	34.49	36.32
FWHM (o)	0.164	0.159	0.178	0.137	0.158	0.161
D (nm)	50.36	52.60	46.98	60.10	57.73	51.89
η (%)	0.250	0.222	0.233	0.210	0.221	0.214

Table 1: The calculations of mean crystal size and lattice strain along preferred orientations of ZnO and BZO ceramics.

Table 2: The lattice constants of ZnO and BZO ceramics.

Samples	a (Å)	c (Å)
ZnO	3.239	5.192
BZO	3.244	5.194



Figure 2: Dependence of electrical conductivity on temperature of pure ZnO (red squares) and BZO (blue circles) ceramics. The error margin of the conductivity is approximately 5%.

Samples	Hall measurement			LSR-3
	n (10^{19} cm^{-3})	$\mu \; (\mathrm{cm}^2 \mathrm{V}^{-1} \mathrm{s}^{-1})$	σ (Scm ⁻¹)	σ (Scm ⁻¹)
ZnO	3.4 ± 0.2	16.7 ± 0.3	90.8 ± 7.1	99.58 ± 6
BZO	1.1 ± 0.3	18.2 ± 0.5	32.0 ± 9.8	45.27 ± 5.72

Figure 4 shows the thermoelectric power factor as a function of temperature. The power factors of the two samples increase significantly with temperature. At 500°C, the PF of the BZO ceramic is found to be 165 μ Wm⁻¹K⁻², which is enhanced by 32% compared to that of the ZnO ceramic (124 μ Wm⁻¹K⁻²). Although Bi doping reduces the electrical conductivity of the BZO sample, its Seebeck coefficient is improved. Therefore, the enhancement of PF is mainly contributed by the compensation of the Seebeck coefficient.

DISCUSSION

The BZO ceramic material has better crystallinity than ZnO due to the increased diffraction intensity,

large crystal size, and reduced lattice strain along with the preferred (100), (002), and (101) orientations (Figure 1). The possible reason can come from the Zn²⁺ substitution of Bi³⁺ with a larger radius. In addition, the Zn²⁺ substitution of Bi³⁺ tends to shrink the unit cell of ZnO. Unexpectedly, the electrical conductivity of BZO is lower than that of the ZnO ceramic (Figure 2). The reduction in electrical conductivity is attributed to the decreased carrier concentration. It is well known that Bi dopants have many oxidation states, including Bi³⁺, Bi²⁺, Bi⁺, and Bi^{0 27,28}. Consequently, the existence of unexpected oxidation states (Bi²⁺, Bi⁺, and Bi⁰) can destroy the electrical characteristics of ZnO. On the other hand, owing to the reduction in carrier concentration, the



Figure 3: Dependence of the Seebeck coefficient on the temperature of pure ZnO (red squares) and BZO (blue circles) ceramics. The error margin of the Seebeck coefficient is approximately 5%.

Seebeck coefficient of the BZO ceramic is significantly enhanced (Figure 3). This trade-off can be described by the following equation $^{29-31}$:

$$S = \frac{8\pi^2 k_B^2}{3eh^2} m_d^* T\left(\frac{\pi}{3n}\right)^2 \frac{2}{3}$$
(5)

where k_B is the Boltzman constant, e is the elementary charge, h is the Plank constant, m_d^* is the effective mass, T is the absolute temperature, and n is the carrier concentration. Through equation (5), S is proportional to $n^{-2/3}$. Consequently, the increased Seebeck coefficient compensates for the diminished electrical conductivity, leading to the enhanced TE power factor.

From the results, despite decreasing the electrical conductivity, Bi doping shows good potential for improving the thermoelectric power factor of the ZnO material due to a significant enhancement in the Seebeck coefficient. In the literature, there have been only a few studies on Bi-doped ZnO ceramic materials. Table 4 illustrates the comparison of the electrical and thermoelectric properties of the Bi-doped ZnO material reported previously. The Bi-doped ZnO obtained from this study has a much higher carrier concentration and mobility than other reports ^{18,32}. This is attributed to the good Zn substitution of Bi, which produces many free carriers and improves the crystalline structure of ZnO. As a result, the electrical conductivity is significantly enhanced, leading to an outstanding value of the power factor of $Zn_{0.98}Bi_{0.02}O$. However, to fully estimate the thermoelectric performance, the thermal conductivity must be determined. This quantity is not considered here and will be investigated in a future study.

CONCLUSION

In this work, the crystallographic, electrical, and thermoelectric properties of ZnO and 2 at.% Bi-doped ZnO are investigated. Through the XRD results, the Bi atoms incorporate well into the host ZnO network, which improves the crystalline structure and the carrier mobility of ZnO. However, because Bi has many oxidation states, Bi doping may damage the charged carrier concentration of ZnO. For the BZO ceramic, the electrical conductivity is reduced to 76 Scm⁻¹, while the Seebeck coefficient is increased to -142 μ VK⁻¹ at 500°C. As a result, the power factor is



Figure 4: Dependence of the power factor on the temperature of pure ZnO (red squares) and BZO (blue circles) ceramics. The error margin of the power factor is less than 10%.

Table 4: Comparison of the electrical and thermoelectric	pro	perties	of Bi-c	begot	ZnO
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Composition	Method	n (cm ⁻³)	μ (cm²/Vs)	σ (S/cm)	S (μV/K)	PF (µW/mK ²)	Ref.
Zn _{0.99} Bi _{0.01} O	Microwaving/Solid-state reaction	$\sim 10^{15}$	15	0.002	-520	0.054 (RT)	18
Zn _{0.98} Bi _{0.02} O	Spark plasma sintering	$\sim \! 10^{18}$	10	2.5	-550	75.6 (700°C)	32
Zn _{0.98} Bi _{0.02} O	Solid-state reaction	$\sim 10^{19}$	18.2	76.1	-142	165 (500°C)	This work

enhanced by 32% to 165 μ Wm⁻¹K⁻². This enhancement is contributed by optimizing the Seebeck coefficient rather than the electrical conductivity.

LIST OF ABBREVIATION

BZO: Bi-doped ZnOPF: Power factorRT: Room temperatureTE: ThermoelectricXRD: X-ray diffraction

COMPETING INTERESTS

The authors declare that they have no competing interests.

AUTHOR CONTRIBUTIONS

Thang Minh Bui synthesized the samples and wrote the draft. Dai Cao Truong wrote the draft. Phung Y Nguyen prepared the samples. Anh Tuan Thanh Pham performed all the measurements and revised the manuscript. Dung Van Hoang and Truong Huu Nguyen took part in the discussion. Thang Bach Phan and Vinh Cao Tran act as scientific supervisors. All the authors have approved the contents of the final version.

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